

Attorney Docket No. ASC-012DV
(058420/157307)
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE LETTERS PATENT OF: Lee *et al.*

PATENT NO. 7,141,820 B2

CONF. NO.: 6105

ISSUE DATE: November 28, 2006

GROUP NO.: 2813

EXAMINER: Nguyen, Tuan H.

TITLE: STRUCTURES WITH PLANAR STRAINED LAYERS

**REQUEST FOR CERTIFICATE OF CORRECTION
UNDER 37 CFR 1.323**

Attn: Certificate of Correction Branch
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Upon reviewing the above-identified patent, Patentee noted an error on the cover page in item (73) Assignee.

Please correct the following error in item (73) Assignee as follows:

Delete “AmberWave Systems Corporation, Salem, NH (US)” and replace with:

--Massachusetts Institute of Technology, Cambridge, MA (US)--

The error now sought to be corrected is an error which occurred upon completion of Form PTOL-85 and does not involve new matter or require reexamination. Massachusetts Institute of Technology is the Assignee of this patent; the assignment is recorded at Reel 015187, Frame 0669. The assignment was submitted for recordation before issuance of the patent.

Transmitted herewith is a proposed Certificate of Correction effecting such amendment.
Patentee respectfully solicits the granting of the requested Certificate of Correction.

A check for \$100.00 was enclosed with Patentee's Request for Certificate of Correction mailed on January 17, 2007. Patentee believes that no other fees are necessitated by the filing of this Request for Certificate of Correction. However, if any other fee is due, please charge said fee to our Deposit Account No. 07-1700.

Date: December 4, 2008

Respectfully submitted,
Electronic Signature: /Natasha C. Us/

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